

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application Serial No.10/655,997
Filing DateSeptember 5, 2003
InventorJon P. Daley
AssigneeMicron Technology, Inc.
Group Art Unit2822
ExaminerPamela E. Perkins
Attorney's Docket No.MI22-2380
Customer No.021567
Title: Methods of Forming Patterned Photoresist Layers Over Semiconductor
Substrates


SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT
References - See Attached Form PTO-1449

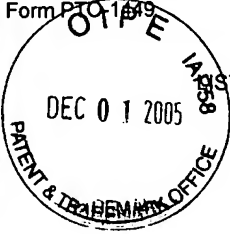
In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

This Supplemental Information Disclosure Statement is being filed before the mailing of a first office action after the filing of a Request for Continued Examination. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. § 1.17(p) to Deposit Account No. 23-0925.

Respectfully submitted,

Dated: 12-1-05

By: 
Mark S. Matkin
Reg. No. 32,268

Form PTO 1549 		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2380		SERIAL NO. 10/655,997	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Jon P. Daley			
U.S. PATENT DOCUMENTS				FILING DATE September 5, 2003		GROUP ART UNIT 2822	
*Examiner's Initials	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
AA	3,772,101	11/1973	Chumbres et al.				
AB	5,677,102	10/1997	Shihara				
AC	6,096,634	08/2000	Nguyen				
AD	6,165,834	12/2000	Agarwal et al.				
AE	6,188,097	02/2001	Derderian et al.				
AF	6,238,994	05/2001	Derderian et al.				
AG	6,255,035	07/2001	Minter et al.				
AH	6,297,527	10/2001	Agarwal et al.				
AI	6,376,149	04/2002	Grober et al.				
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
AJ							
AK							
AL							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AM						
	AN						
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U.S. PATENT DOCUMENTS							
*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	6,399,982	06/2002	Derderian et al.			
	AB	6,511,896	01/2003	Basceri et al.			
	AC	6,608,343	08/2003	Derderian et al.			
	AD	6,617,250	09/2003	Basceri et al.			
	AE	6,649,466	11/2003	Basceri et al.			
	AF	6,744,093	06/2004	Agarwal et al.			
	AG	6,746,916	06/2004	Agarwal et al.			
	AH	6,777,739	08/2004	Agarwal et al.			
	AI	6,780,766	08/2004	Basceri et al.			

FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AJ							
	AK							
	AL							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)			
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U.S. PATENT DOCUMENTS							
*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	6,817,086	11/2004	Lu et al.			
	AB	6,900,497	05/2005	Agarwal et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

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